

Supporting Information

Ultrafast photoresponse of vertically oriented TMD films probed in a vertical electrode configuration on Si chips

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Table S1. Collected element stoichiometry from EDX analysis on the MoS₂ and WS₂ films.

| Element | O | Si | S | W | Mo | M:S ratio |
|------------------|------|-----|------|------|------|-----------|
| MoS ₂ | 5.7 | 1.4 | 60.9 | - | 31.1 | 1:1.93 |
| WS ₂ | 69.9 | 1.9 | 5.5 | 22.2 | - | 1:0.25 |

Table S2. XPS peak assignment.

| Sample | Peak | Binding energy (eV) | Assignment |
|------------------|-------|---------------------|-------------------------------|
| MoS ₂ | C 1s | 284.7 | C–C |
| | | 286.0 | C–O |
| | | 288.9 | C=O |
| | O 1s | 530.6 | Mo–O |
| | | 531.4 | C=O |
| | | 532.4 | –OH |
| | S 2p | 162.0 | Mo–S |
| | | 163.3 | Mo–S |
| | | 168.5 | SO ₃ ²⁻ |
| | | 169.6 | SO ₄ ²⁻ |
| | Mo 3d | 229.4 | Mo–S |
| | | 230.9/234.2 | Mo ⁴⁺ |
| | | 231.7/235.0 | Mo ⁵⁺ |
| 232.9/236.1 | | Mo ⁶⁺ | |
| WS ₂ | C 1s | 284.7 | C–C |
| | | 286.3 | C–O |
| | | 289.0 | C=O |
| | O 1s | 530.7 | W–O |
| | | 531.6 | C=O |
| | | 532.4 | –OH |
| | S 2p | 162.7 | W–S |
| | | 168.7 | SO ₃ ²⁻ |
| | | 169.8 | SO ₄ ²⁻ |
| | W 4f | 31.0/34.6 | W–S |
| | | 36.0/38.1 | W–O |

AEY and TEY analysis

Figure S1 A and B show the AEY and TEY spectra of C1s edge for WS₂ sample. On the TEY spectra, the peaks at 285.3 and 288.65 eV are assigned to the transitions of C 1s electrons to the p* molecular orbital of C=C in the sp² network and C=O in the carboxyl groups (COOH), respectively.^{1,2} The σ* region is typically characterized by features ranging from 291 eV for single bonds carbon to 310 eV for triple bonds.^{3,4} Thus, the peak at 294.25 eV matches the σ* excitation of C-O bonding apparently in the acrylic acid configuration.⁵ And the broad peak at 301.86 eV can originate from the sigma features of C=O and C=C in the carboxyl and acrylic acid, respectively.^{1,5} The sharp peak at 308.26 eV in the AEY spectra, in contrast to the relatively broad features of the σ region, is likely arising from Si2p 3rd order which is visible only in the WS₂ sample as some Si is exposed through the film.¹

For the MoS₂, the spectra follow the same trend, Fig. S1 C and D. At 285.3 and 288.65 eV, the absorption edges correspond to the transitions of C1s electrons to the p* C=C molecular orbital in sp² bonding and C=O molecular orbital in carboxyl groups, respectively.^{1,2} The peak at 293.35 eV can be assigned to σ* excitation for carbon single bonded to oxygen (C-O), probably in Methyl formate configuration (~ 293.7 eV),⁵ while the peak at 297.35 eV corresponds to σ* resonance of single-bonded carbon and oxygen either in C-OH or C-O-C configuration.² And the peak at 299.95 eV is very close to the σ*(C=C) resonance in propenol that is around 300 eV.^{2,5}

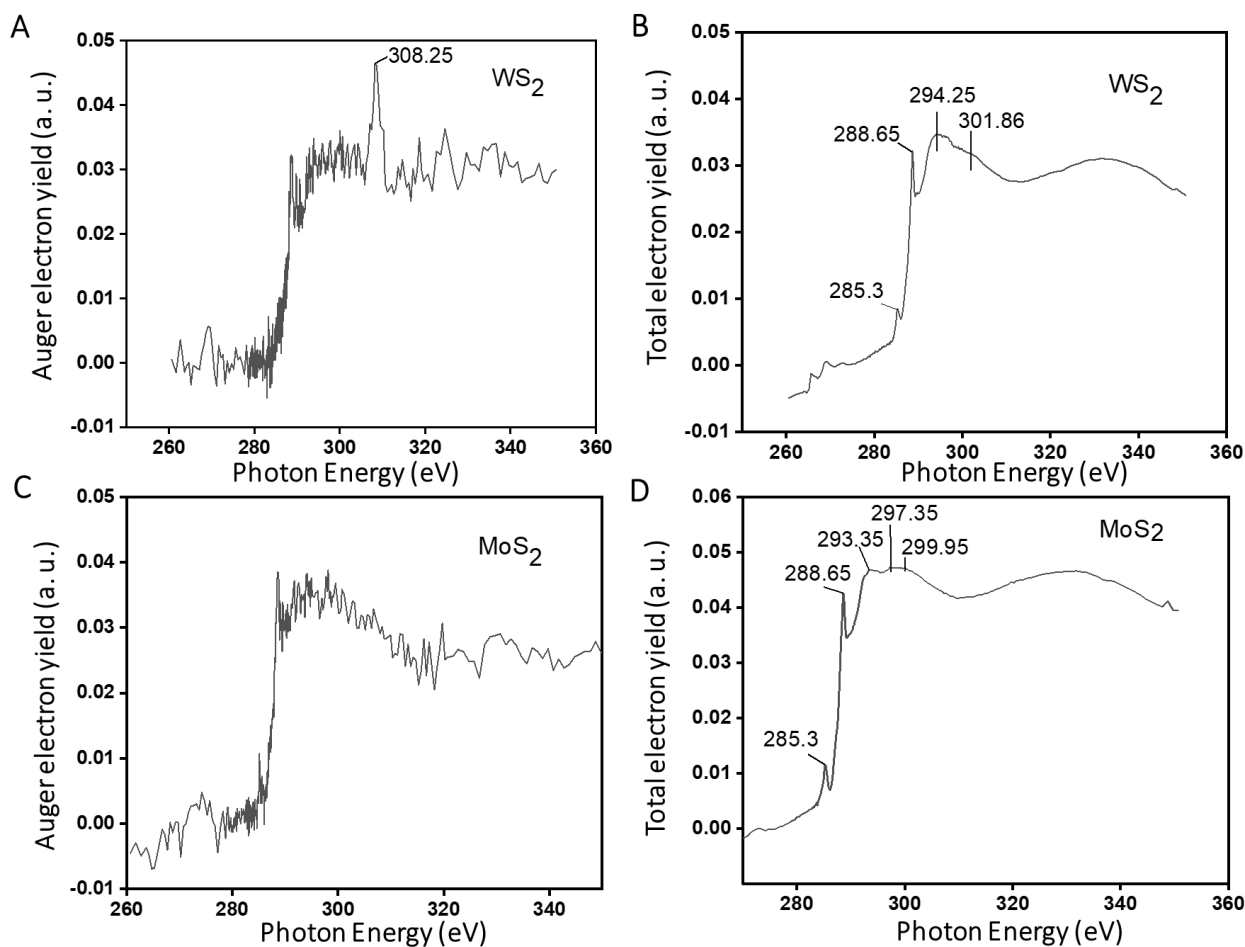


Figure S1. C 1s edge absorption spectra for WS₂ in (A) AEY and (B) TEY mode and for MoS₂ in (C) AEY and (D) TEY mode.

The O K edge absorption spectra contain features of oxygen-carbon bonding as a surface contaminant; however, in contrast to the carbon, the spectra show metal-oxygen bonding as well, **Figure S2**. For the WS₂ sample, the pre-edge at 530.25 eV represents the t_{2g} band formed by W 5d and O 2p orbitals, Fig. S2 A and B, while the shoulder at 531.6 eV is related to the anisotropy of this band.^{2,6,7} It is worth mentioning that the π^* resonances from double-bonded oxygen to carbon (carbonyl, C=O) are also expected around 530.8 and 531.8 eV.² The e_g peak (formed by W 5d and O 2p hybridization) cannot be well resolved here due to the overlap of the wide feature at 536.75 eV. The relatively lower intensity of t_{2g} peak compared to e_g , in contrast to previous studies, might be attributed to the modification of the chemical environment of W–O bonding (e.g., the W reduction in WO₃ to the W₃O phase transition as reported in our previous study^{3,7,8}) or the association of the broad peak at 536.75 eV.

The relatively wide feature at 542.04 eV corresponds to the W 6sp and O 2p hybridization, leading to energy separation of $D(E_{sp} - E_{d1})$ around 11.79 eV that is in good agreement with the previous

reports.^{3,9} Finally, with the peak at 564.65 eV, corresponding to the scattering resonances at the nearest atoms, the TEY spectrum resembles that of the α - WO_3 spectra reported in the literature.^{3,6} The O K edge absorption for the MoS_2 sample follows the same analogy, Figure S2 C and D, resembling the α - MoO_3 spectra.^{3,9} The peaks at 529.75 eV and 531.9 eV correspond to the t_{2g} band formed by Mo 4d and O 2p hybridization.⁶ While the wide feature at 537.15 is probably overlap of peaks resulting from the e_g orbital, and s^* resonance of single-bonded oxygen in either C-O-C or C-O-H configurations.^{2,3,6} The peaks at 542.85 and 562.75 eV, same as the WS_2 sample, correspond to the Mo 5sp and O 2p hybridization and the scattering resonances at the nearest atoms, respectively.⁶

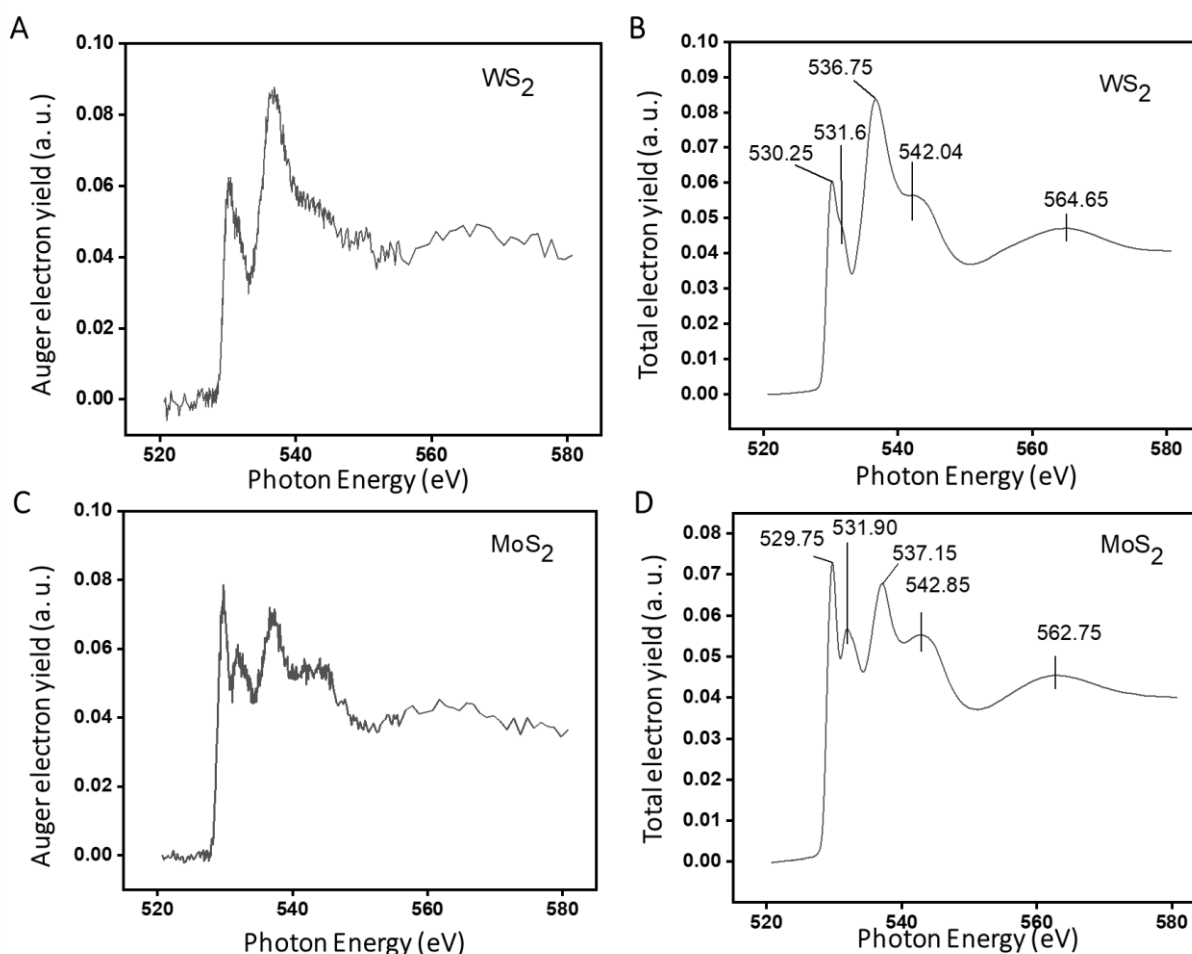


Figure S2. O 1s edge absorption spectra for WS_2 in (A) AEY and (B) TEY mode and for MoS_2 in (C) AEY and (D) TEY mode.

Finally, the molybdenum oxidation state was calculated, via a linear relationship, from the energy positions of Mo M-edge features. The polarization-dependent spectra of Mo $M_{2,3}$ were collected with a grazing incidence angle of 20° , 55° , and 90° , **Figure S3**. For the AEY spectra, limited to a depth profile of 1 nm, the peaks originating from the N atom, appearing in the same spectral range,

are probably dominant, while for TEY spectra, with a depth profile of 10 nm, the Mo $M_{2,3}$ absorption edges are prominent.

The Mo M_3 edge absorption, at 398.5 and 400.5 eV³, implies the partial oxidation of the MoS₂ surface with the oxidation state of +6 (instead of +4) for Mo.¹⁰

The other peaks at 415.5 and 418.1 eV are ascribed to the Mo M_2 edge, while the broad and polarization-dependent peak at 406.9 eV can be assigned to the N K edge absorption.^{11,12}

For clarity and comparison, the peak assignments are summarized in **Table S3** and **S4**.

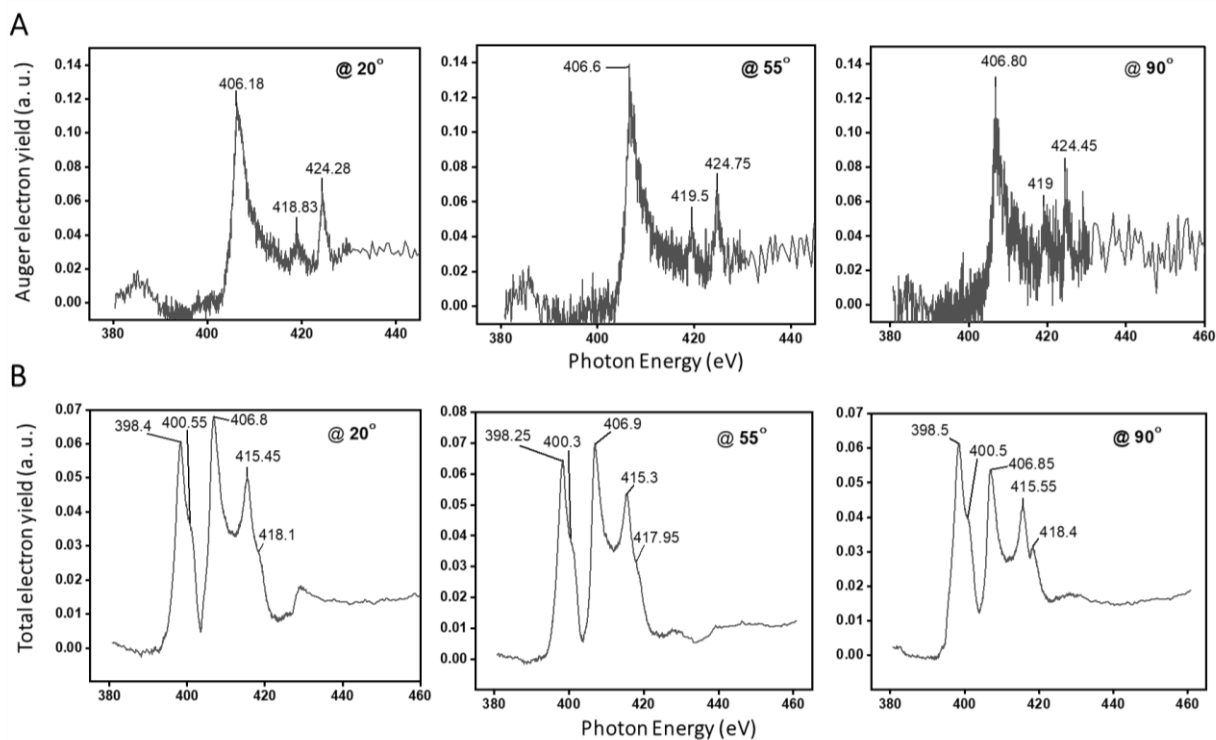


Figure S3. (A) AEY and (B) TEY spectra of Mo $M_{2,3}$ edge absorption at incidence angle of 20°, 55°, and 90°.

Table S3. C 1s and O 1s peak assignment at incidence angle of 55° for MoS₂ and WS₂ samples.

| Sample | Peak | Spectra | Photon energy (eV) | Assignment (transition) | Ref. |
|------------------|------|---------|--------------------|---|-------|
| WS ₂ | C 1s | TEY | 285.3 | π^* (C=C) | 1,2 |
| | | TEY | 288.65 | π^* (C=O) resonances in carboxyl groups (COOH) | 1,2 |
| | | TEY | 294.25 | σ^* (C-O) | 5 |
| | | TEY | 301.86 | σ^* (C=C or C=O) | 1,5 |
| | | AEY | 308.26 | Si 2p | 1 |
| | O 1s | TEY | 530.25 | t_{2g} (hybridized orbitals of W 5d + O 2p) | 2,6,7 |
| | | TEY | 531.6 | t_{2g} (hybridized orbitals of W 5d + O 2p) | 2,6,7 |
| | | TEY | 536.75 | e_g (hybridized orbitals of W 5d + O 2p) or σ^* (C-OH / C-O-C) | 2,3 |
| | | TEY | 542.04 | Hybridized orbitals of (W 6sp+ O 2p) | 3,9 |
| | | TEY | 564.65 | Scattering resonances at the nearest atoms | 3,6 |
| MoS ₂ | C 1s | TEY | 285.25 | π^* (C=C) | 1,2 |
| | | TEY | 288.65 | π^* (C=O) resonances in carboxyl groups (COOH) | 1,2 |
| | | TEY | 293.35 | σ^* (C-O) | 5 |
| | | TEY | 297.35 | σ^* resonance attributed to single-bonded oxygen e.g., C-OH or C-O-C | 2 |
| | | TEY | 299.95 | σ^* (C=C) | 2,5 |
| | O 1s | TEY | 529.75 | t_{2g} (hybridized orbitals of Mo 4d + O 2p) | 6 |
| | | TEY | 531.9 | t_{2g} (hybridized orbitals of Mo 4d + O 2p) | 6 |
| | | TEY | 537.15 | e_g (hybridized orbitals of Mo 4d + O 2p) or σ^* (C-OH / C-O-C) | 2,6 |
| | | TEY | 542.85 | Hybridized orbitals of (Mo 5sp+ O 2p) | 3,9 |
| | | TEY | 562.75 | Scattering resonances at the nearest atoms | 6 |

Table S4. Mo M_{III} and M_{II} edge absorption at incidence angle of 20°, 55°, and 90°.

| Photon energy (eV) | | | Assignment (transition) | Ref. |
|--------------------|--------|--------|-------------------------------------|-------|
| 20° | 55° | 90° | | |
| 398.4 | 398.25 | 398.5 | M _{III} (t _{2g}) | 3,10 |
| 400.55 | 400.3 | 400.5 | M _{III} (e _g) | 3 |
| 406.8 | 406.9 | 406.85 | N-O/H/Si | 11,12 |
| 415.45 | 415.3 | 415.55 | M _{II} (t _{2g}) | 3 |
| 418.1 | 417.95 | 418.4 | M _{II} (e _g) | 3 |

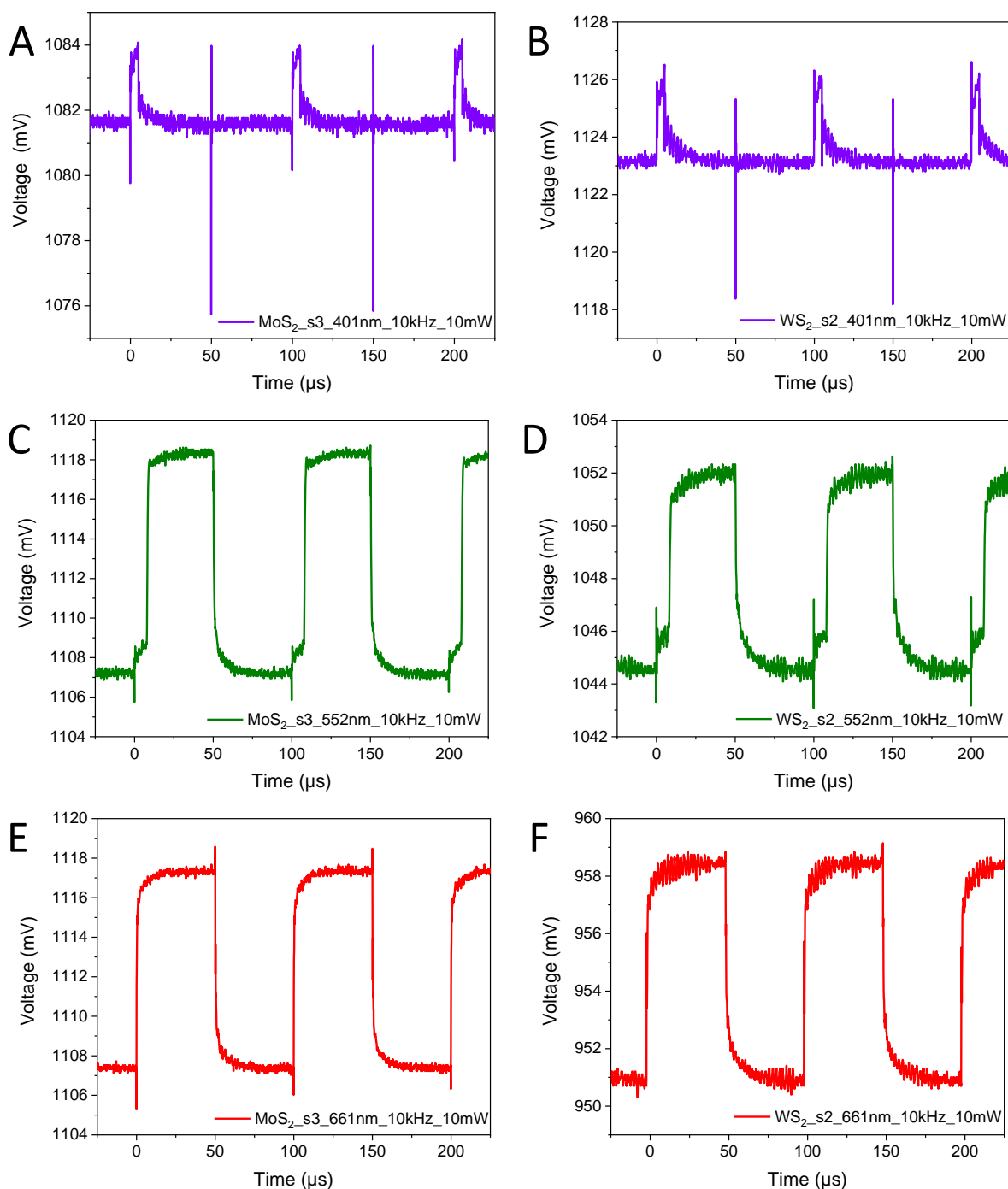


Figure S4. Example of raw waveforms used in photoresponse statistics calculations. Note that the 405 nm was pulsed at 5% duty cycle (A for MoS₂, B for WS₂) whereas 552 nm and 661nm were pulsed at 50 % duty cycle. In case of 552 nm pulses a slight delay in full laser power delivery can be seen in the rising edge.

Table S5. Collected response times with both 10-90% and double exponential fittings from 50-point averaged 1 MHz signals at 661 nm.

| Sample | Rise time 10-90% (ns) | Decay time 90-10 % (ns) | Rise time with double exponential fitting t_1 / t_2 (ns) | Decay time with double exponential fitting t_1 / t_2 (ns) |
|------------------------|------------------------------|--------------------------------|--|---|
| MoS₂ | 250 | 370 | 11 / 86 | 49 / 113 |
| WS₂ | 330 | 400 | 78 / 80 | 115 / 115 |

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